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**Examiner**

Jinhee J. Lee

**Applicant(s)/Patent under  
Reexamination**

YAJIMA ET AL.

**Art Unit**

2174

**SEARCHED**

Class	Subclass	Date	Examiner
715	712	3/14/2008	LEE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search attached	3/14/2008	LEE